

FIG. 1

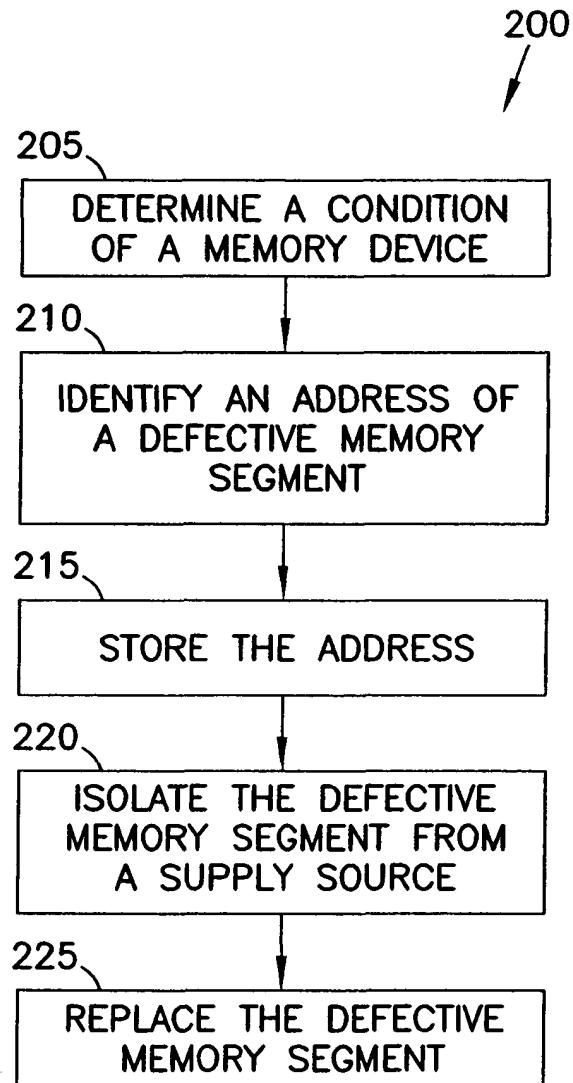


FIG. 2

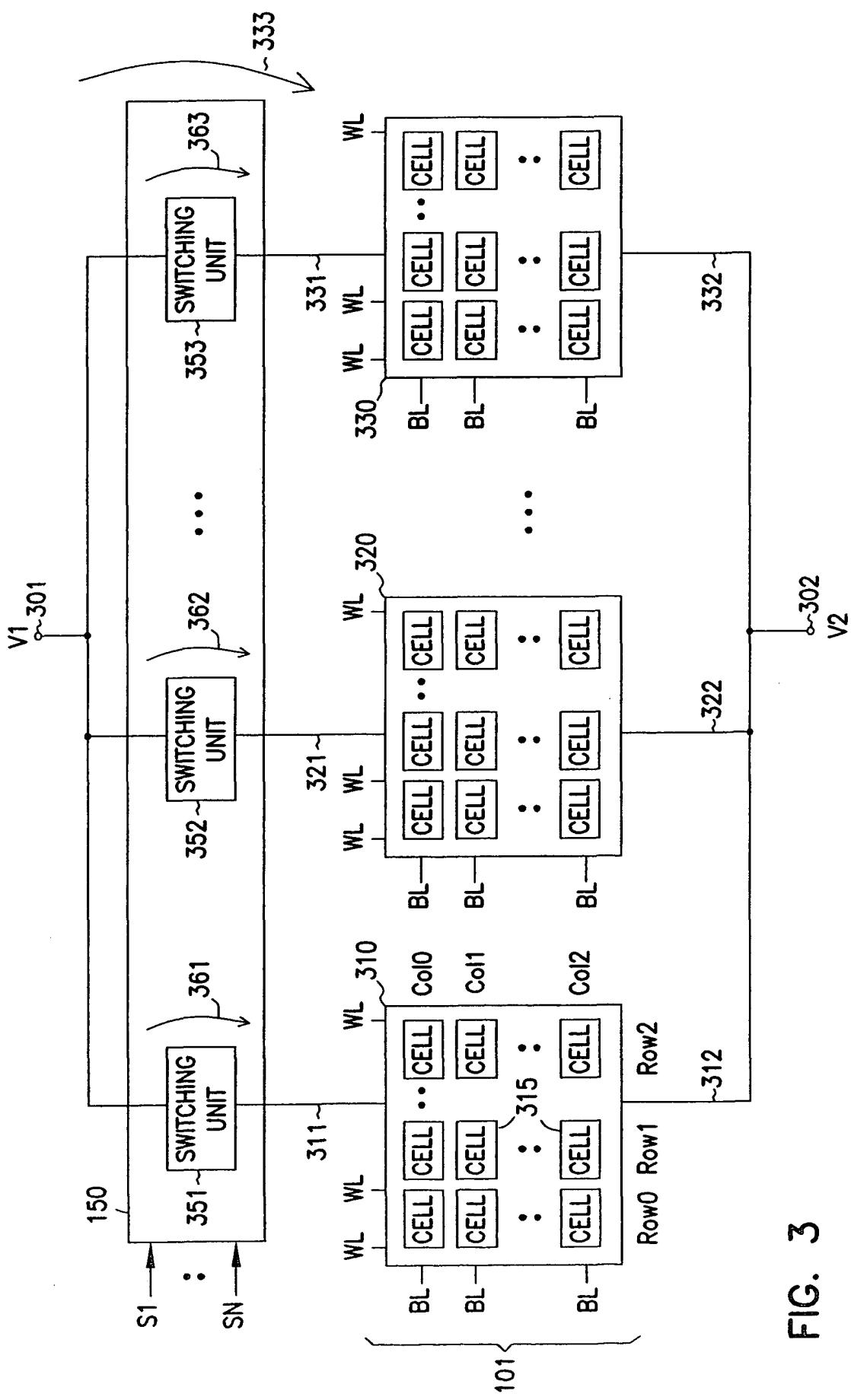


FIG. 3

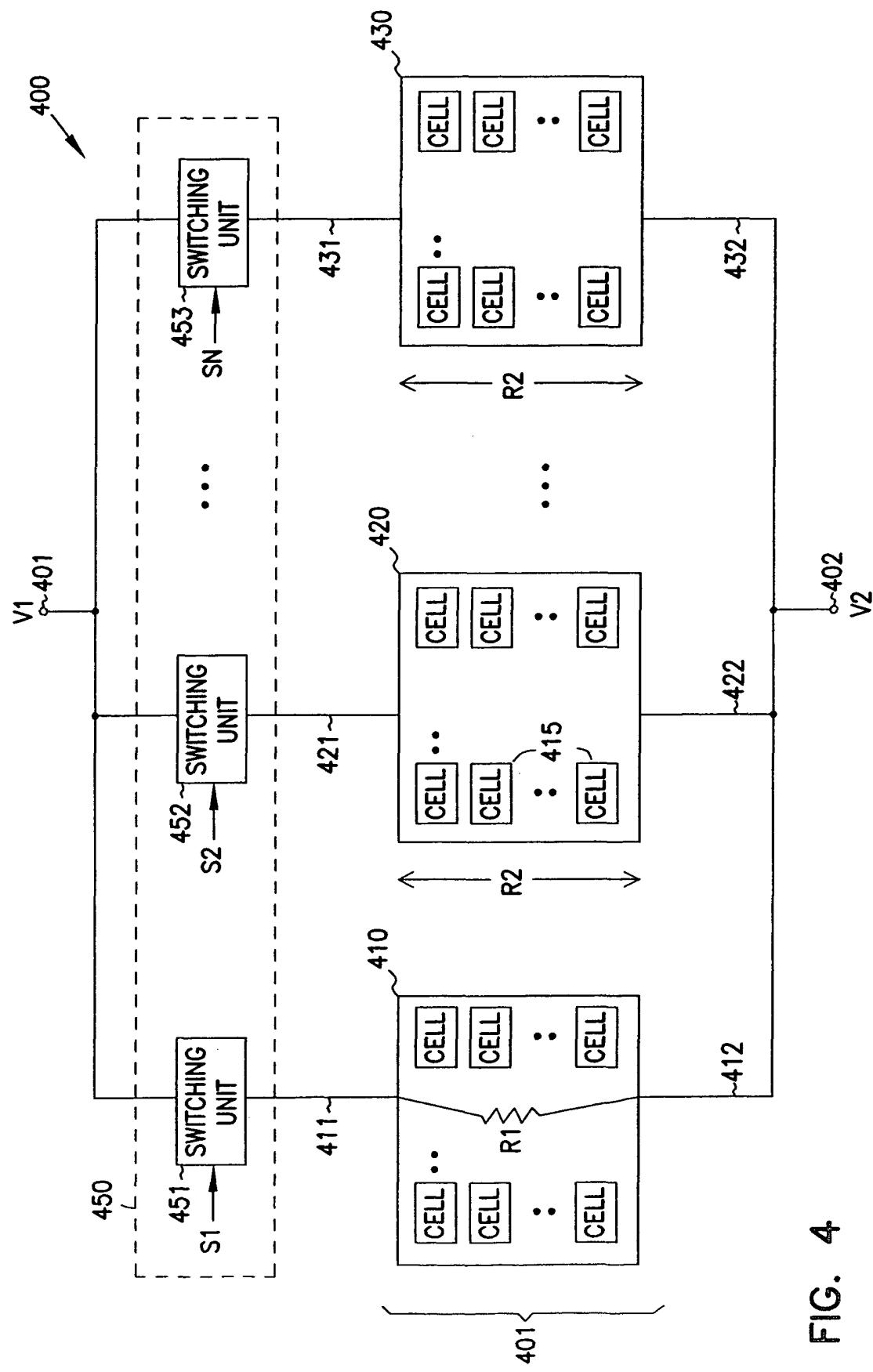


FIG. 4

TITLE: CIRCUITS AND METHODS FOR REPAIRING DEFECTS IN MEMORY DEVICES  
INVENTOR: KEN MARR  
DOCKET NO.: 303.859US1

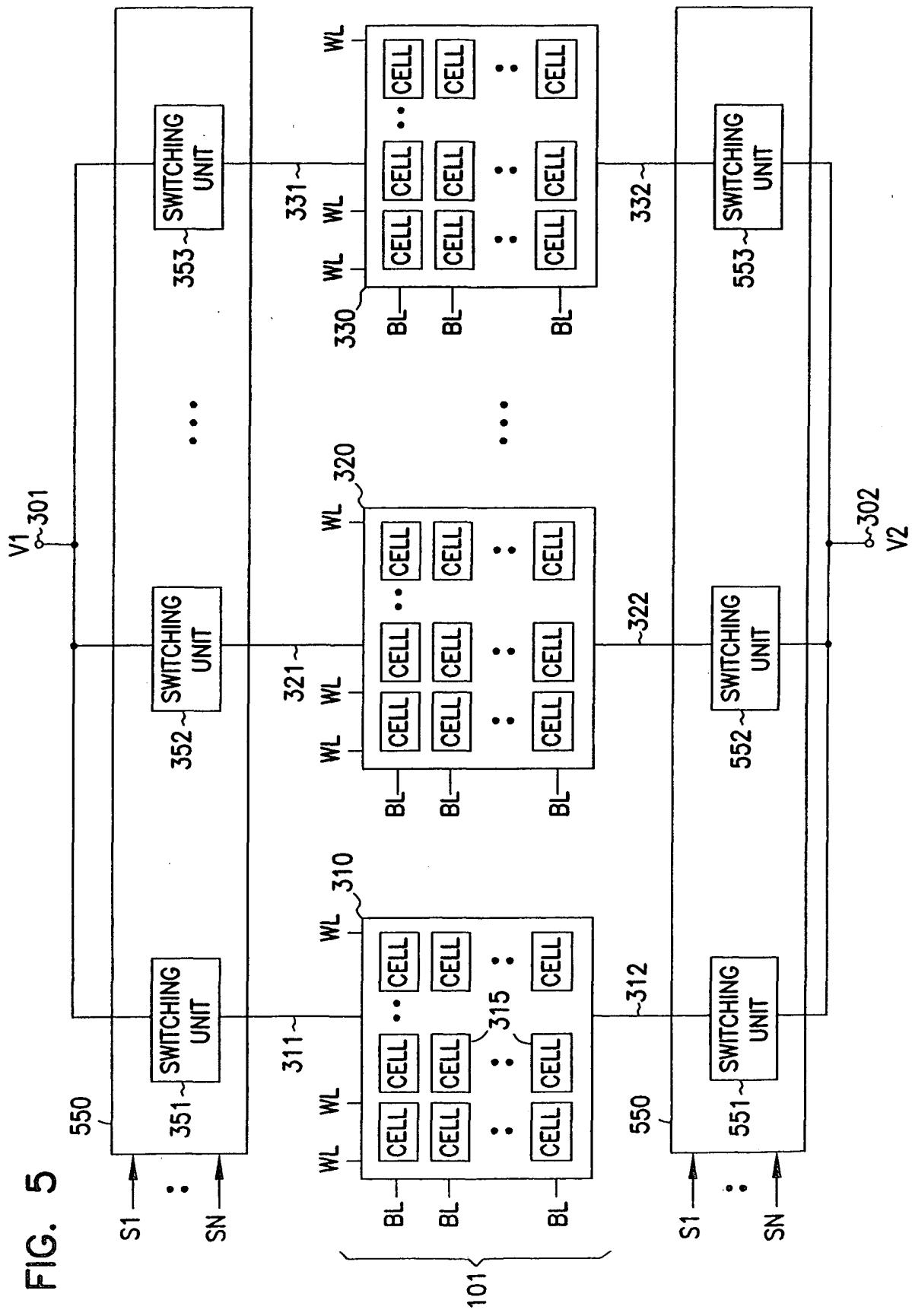
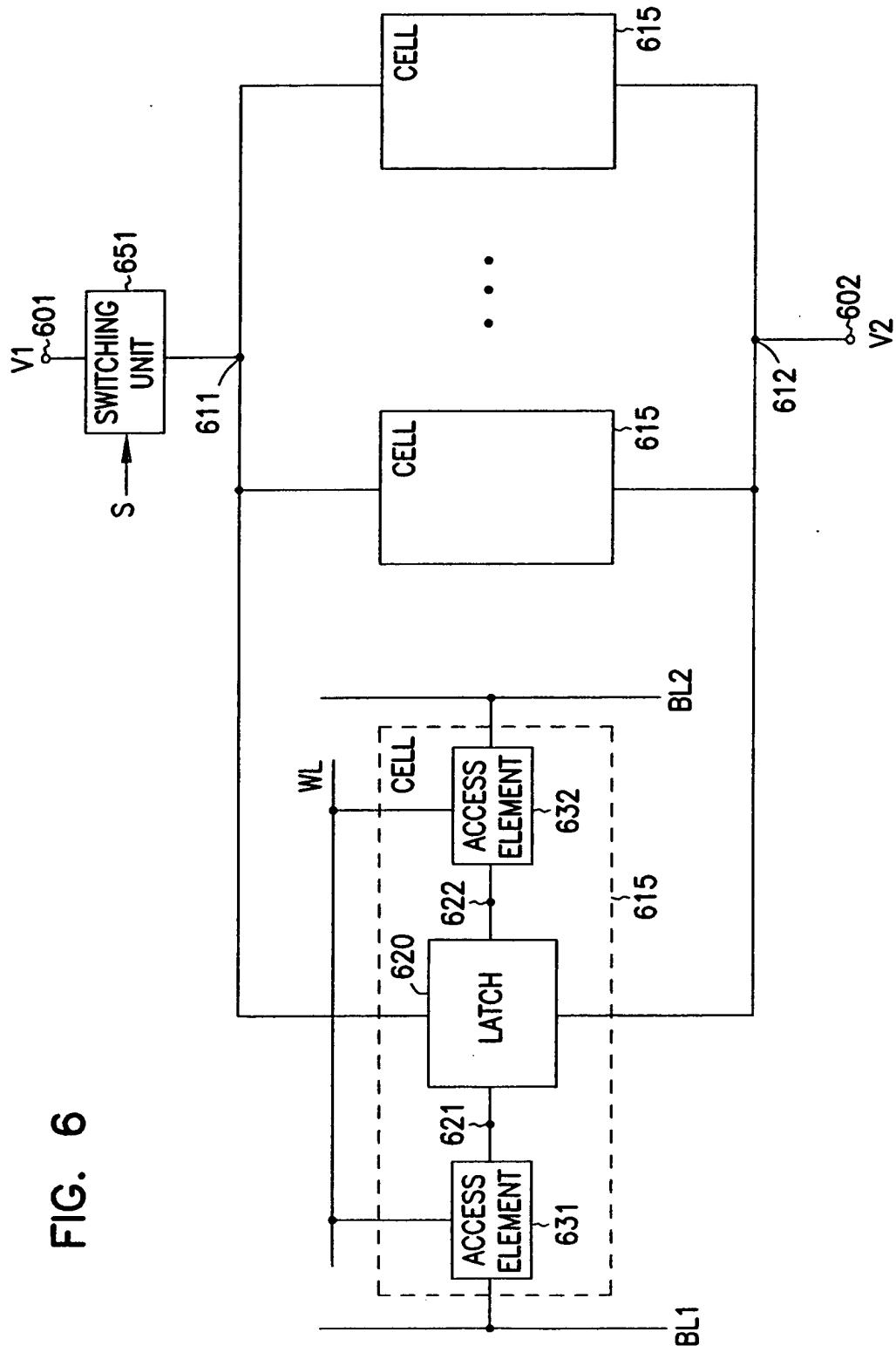


FIG. 6



TITLE: CIRCUITS AND METHODS FOR REPAIRING DEFECTS IN MEMORY DEVICES  
INVENTOR: KEN MARR  
DOCKET NO.: 303.859US1

FIG. 7

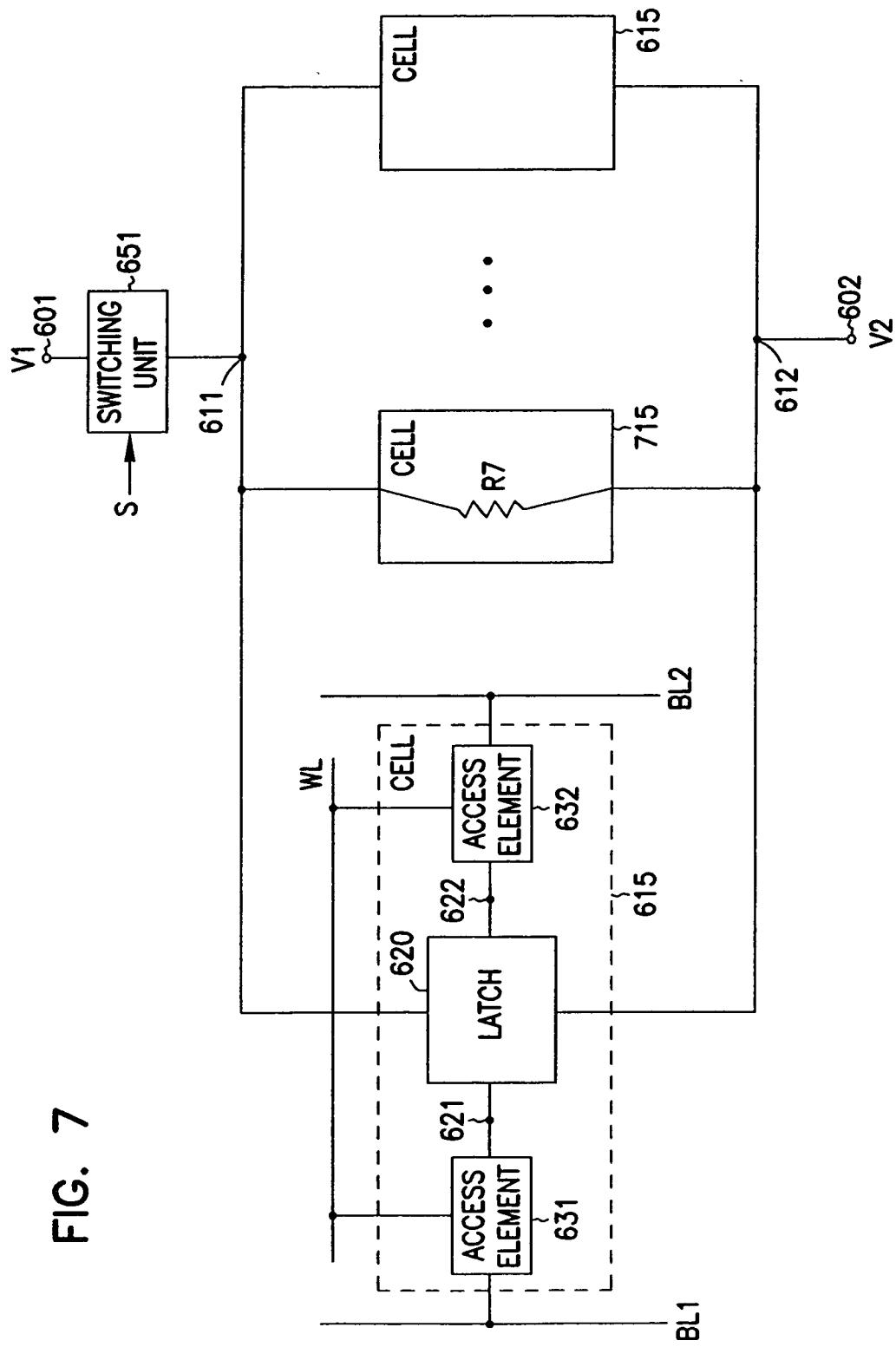
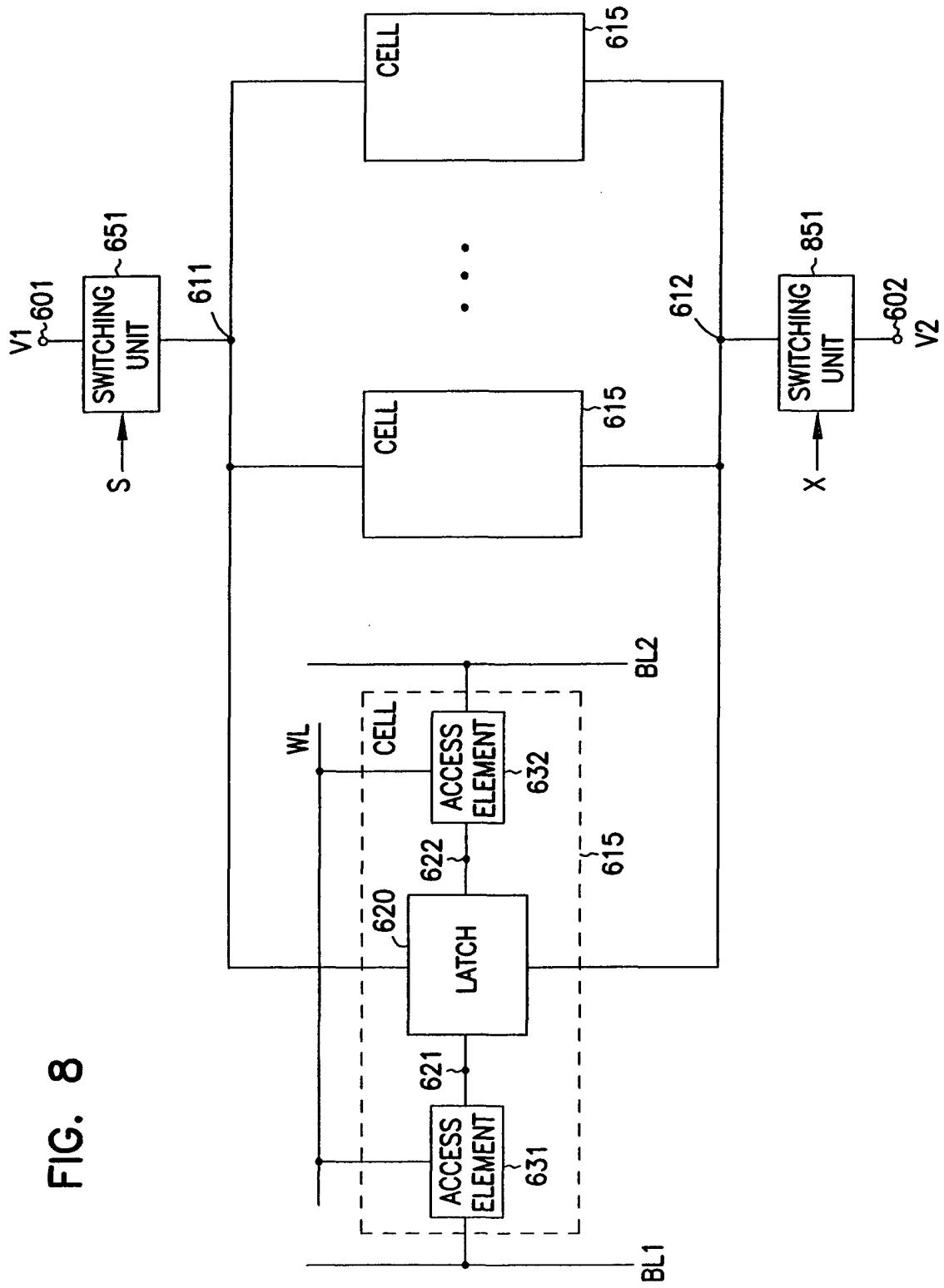


FIG. 8



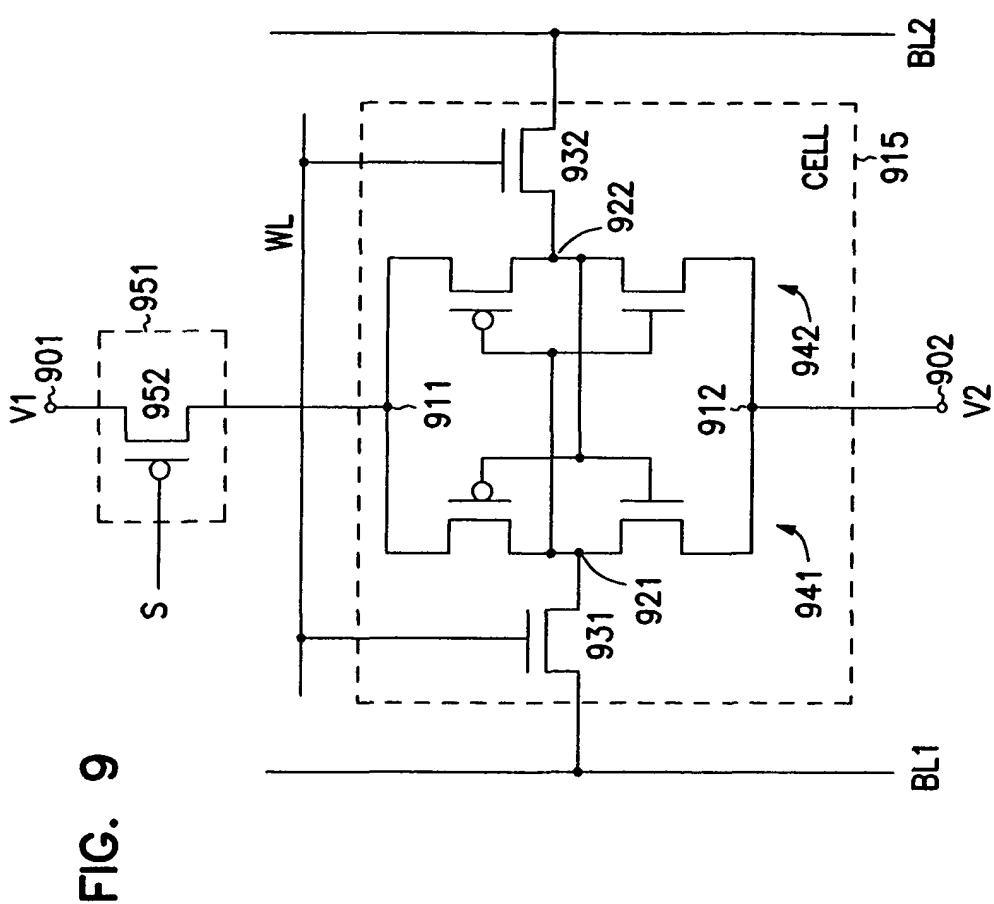
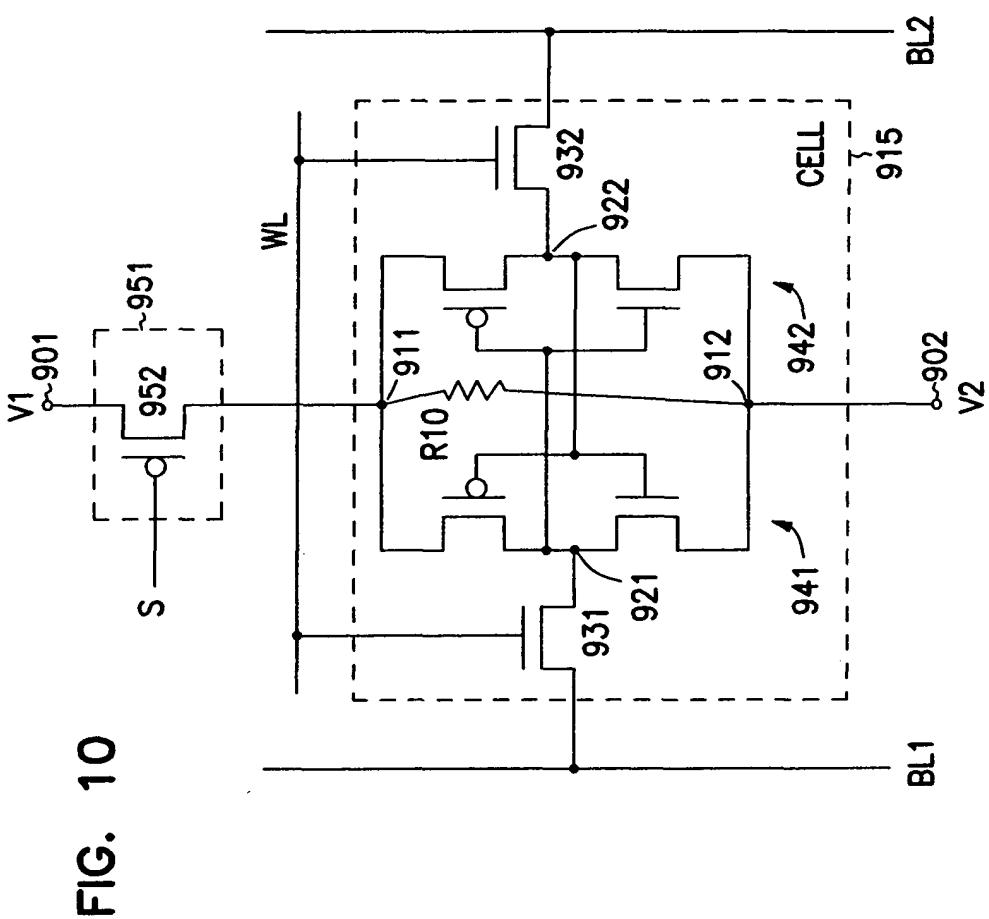


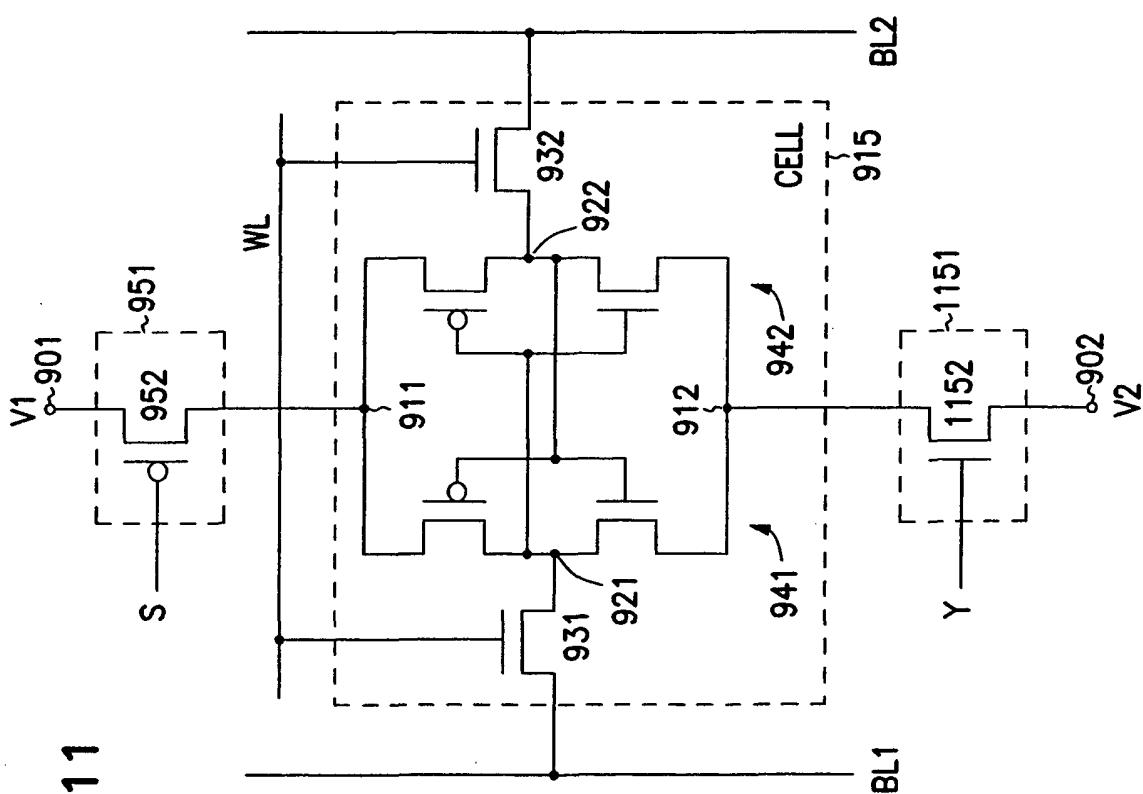
FIG. 9

TITLE: CIRCUITS AND METHODS FOR REPAIRING DEFECTS IN MEMORY DEVICES  
INVENTOR: KEN MARR  
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FIG. 11



TITLE: CIRCUITS AND METHODS FOR REPAIRING DEFECTS IN MEMORY DEVICES  
INVENTOR (S): KEN MARR  
DOCKET NO.: 303.859US1

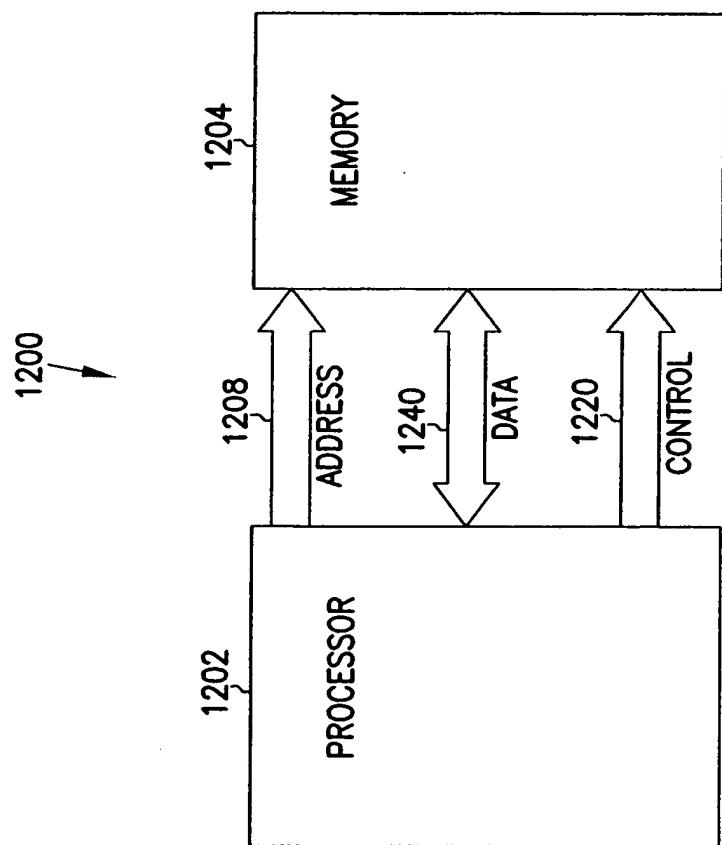


FIG. 12